Searcn Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination
10/751,153	FINE ET AL.

Examiner

Frank Duong

Art Unit 2616

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SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search (see printout)	8/1/2007	FD	
Inventorship Search (see printout)	8/1/2007	FD	
IEEE/Internet Search	8/1/2007	FD	